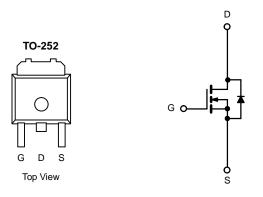


N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ)			
40	0.0021 at V _{GS} = 10 V	160 (Silicon Limited)	60 nC			
	0.0021 at 1GS = 10 V	120 (Package Limited)	00110			



N-Channel MOSFET

FEATURES

- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested
 Compliant to RoHS Directive 2011/65/EU



APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	40	V		
Gate-Source Voltage		V_{GS}		± 20	
	T _C = 25 °C		160		
Drain Current (Silicon Limited)	T _C = 70 °C		120	A	
Ocationary Paris Ocarres (T. 475.00)	T _A = 25 °C	I _D	120 ^{a, e}		
Continuous Drain Current (T _J = 175 °C)	T _A = 70 °C		105 ^{a, e}		
Pulsed Drain Current		I _{DM}	390		
Avalanche Current Pulse		I _{AS}	45		
Single Pulse Avalanche Energy	gy E = 0.1 IIII1	E _{AS}	240	mJ	
Source-Drain Diode Current(Silicon Limited)	T _C = 25 °C	l _a	150 ^{a, e}	A	
Course Drain Blode Current(Cincon Limited)	T _A = 25 °C	I _S	3.93 ^{b, c}	A	
	T _C = 25 °C		150 ^a		
Maximum Davier Dissipation	T _C = 70 °C	P _D	125	\Box w	
Maximum Power Dissipation	T _A = 25 °C	' D	3.75 ^{b, c}	vv	
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Rai	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 sec	R _{thJA}	14	20	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	- *C/VV	

Notes:

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.

- b. Striate informed on 1 X 1 114 board.
 c. t = 10 sec.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		m\//9C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Walkana Basis Osamasi	I _{DSS}	$V_{DS} = 32 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 32 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			1	μA	
Zero Gate Voltage Drain Current					10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$			160	Α	
		$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$	+ + + + + + + + + + + + + + + + + + + +		0.0027	_	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0033	0.0038	Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 32V, I_{D} = 30 A$		60		S	
Dynamic ^b					<u> </u>		
Input Capacitance	C _{iss}			2968		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		822			
Reverse Transfer Capacitance	C _{rss}			72			
·	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		60	76	nC	
Total Gate Charge				51.5	103		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 30 \text{ A}$		10			
Gate-Drain Charge	Q _{gd}			10			
Gate Resistance	R _g	f = 1 MHz		1.2	1.8	Ω	
Turn-On Delay Time	t _{d(on)}			10	18		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		5	10		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 30 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		35	65		
Fall Time	t _f			5	10		
Turn-On Delay Time	t _{d(on)}			30	43	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		100	170		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		32	53		
Fall Time	t _f			10	15	1	
Drain-Source Body Diode Characteristic	s				<u> </u>		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			150	۸	
Pulse Diode Forward Current ^a	I _{SM}				390	Α	
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			22	28	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20 A di/dt = 100 A/vo T = 25 °C		50.2	68	nC	
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		27		,	
Reverse Recovery Rise Time	t _b			25		ns	

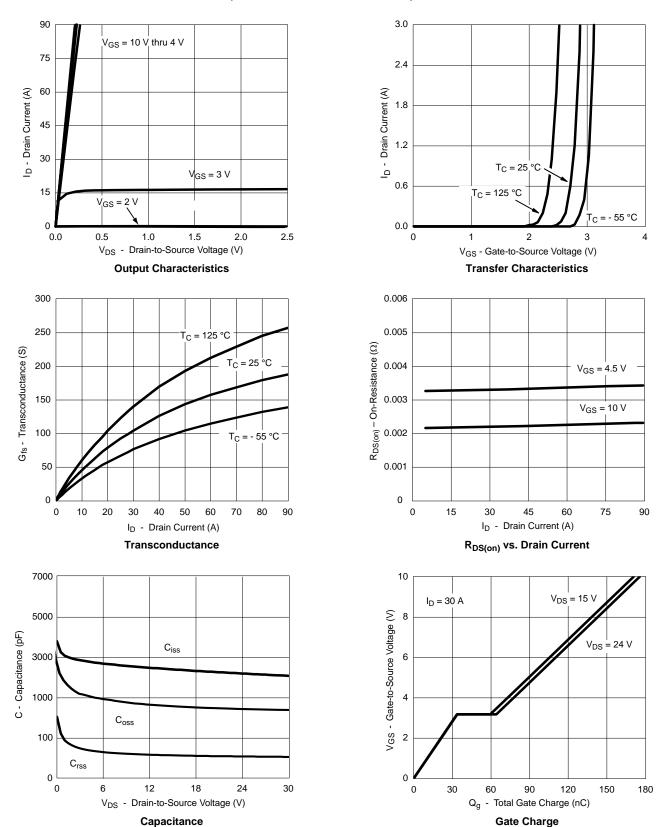
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

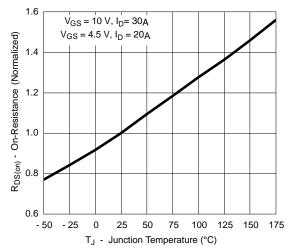
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



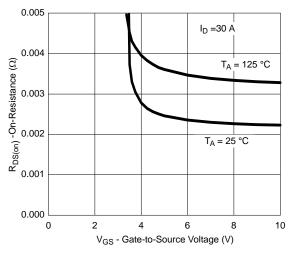
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



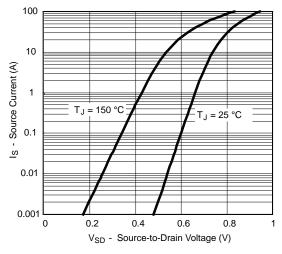
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



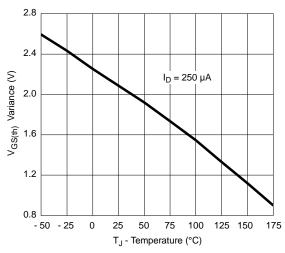
On-Resistance vs. Junction Temperature



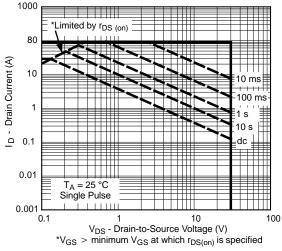
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature

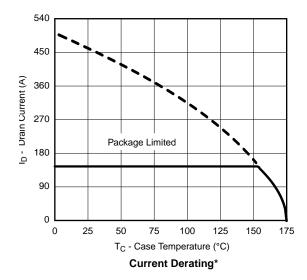


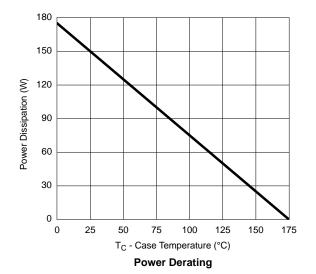
Threshold Voltage



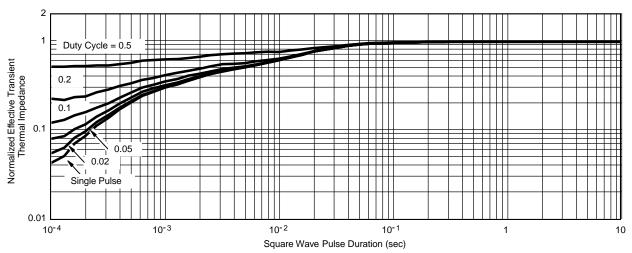
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





*The power dissipation P_D is based on $T_{J(max)}$ = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

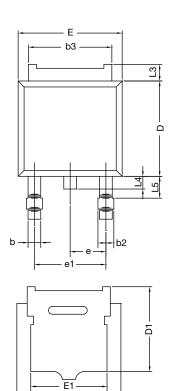


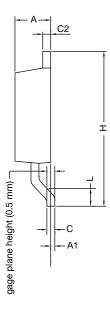
Normalized Thermal Transient Impedance, Junction-to-Case





TO-252AA CASE OUTLINE



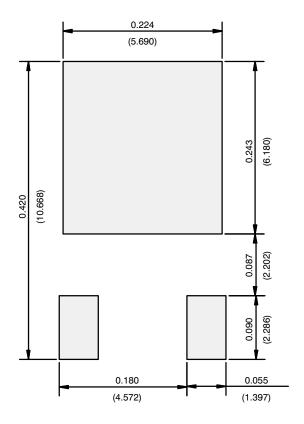


MILLIMETERS			INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	2.18	2.38	0.086	0.094		
A1	-	0.127	-	0.005		
b	0.64	0.88	0.025	0.035		
b2	0.76	1.14	0.030	0.045		
b3	4.95	5.46	0.195	0.215		
С	0.46	0.61	0.018	0.024		
C2	0.46	0.89	0.018	0.035		
D	5.97	6.22	0.235	0.245		
D1	5.21	-	0.205	-		
Е	6.35	6.73	0.250	0.265		
E1	4.32	-	0.170	-		
Н	9.40	10.41	0.370	0.410		
е	2.28	2.28 BSC		BSC		
e1	4.56 BSC		0.180 BSC			
L	1.40	1.78	0.055	0.070		
L3	0.89	1.27	0.035	0.050		
L4	-	1.02	-	0.040		
L5	1.14	1.52	0.045	0.060		
ECN: X12-0247-Rev. M, 24-Dec-12						

DWG: 5347 Note

• Dimension L3 is for reference only.

RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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